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# IRF610-613 MTP2N18/2N20 N-Channel Power MOSFETs, 3.5 A, 150-200 V

Power And Discrete Division

#### Description

These devices are n-channel, enhancement mode, power MOSFETs designed especially for high speed applications, such as switching power supplies, converters, AC and DC motor controls, relay and solenoid drivers and other pulse circuits.

- Low R<sub>DS(on)</sub> V<sub>GS</sub> Rated at ± 20 V
- · Silicon Gate for Fast Switching Speeds
- IDSS, VDS(on), Specified at Elevated Temperature
- Rugged

 $P_{D}$ 

- Low Drive Requirements
- Ease of Paralleling

#### TO-220AB



IRF610 IRF611 IRF612 IRF613 MTP2N18 MTP2N20

Symbol	Characteristic	Rating IRF610/612 MTP2N20	Rating MTP2N18	Rating IRF611/613	Unit
V <sub>DSS</sub>	Drain to Source Voltage <sup>1</sup>	200	180	150	V
V <sub>DGR</sub>	Drain to Gate Voltage¹ R <sub>GS</sub> = 20 kΩ	200	180	150	٧
V <sub>GS</sub>	Gate to Source Voltage	± 20	± 20	± 20	٧
TJ, T <sub>stg</sub>	Operating Junction and Storage Temperatures	-55 to +150	-55 to +150	-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purposes, 1/8" From Case for 5 s	275	275	275	.c
laximum	On-State Characteristics				
		IRF610/611	MTP2N18/20	IRF612/613	
R <sub>DS(on)</sub>	Static Drain-to-Source On Resistance	1.5	1.8	2.4	Ω
a ا	Drain Current Continuous at T <sub>C</sub> = 25°C Continuous at T <sub>C</sub> = 100°C Pulsed	2.5 1.5 10	3.25 2.25 9.0	2.0 1.25 8.0	A
/laximum	Thermal Characteristics				
Røjc	Thermal Resistance, Junction to Case	6.4	2.5	6.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	80	80	80	°C/W

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NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

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**Quality Semi-Conductors** 

Total Power Dissipation

at T<sub>C</sub> = 25°C

# IRF610-613 MTP2N18/2N20

Symbol	Characteristic	Min	Max	Unit	Test Conditions	
Off Charac	teristics					
V <sub>(BR)DSS</sub>	Drain Source Breakdown Voltage <sup>1</sup>			V	$V_{GS} = 0 \text{ V, } I_D = 250  \mu\text{A}$	
	IRF610/612/MTP2N20	200		]		
	MTP2N18	180				
	IRF611/613	150				
l <sub>DSS</sub>	Zero Gate Voltage Drain Current		250	μА	V <sub>DS</sub> = Rated V <sub>DSS</sub> , V <sub>GS</sub> = 0 V	
			1000	μА	$V_{DS} = 0.8 \text{ x Rated } V_{DSS},$ $V_{GS} = 0 \text{ V}, T_C = 125^{\circ}\text{C}$	
less	Gate-Body Leakage Current		± 500	nA	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	
On Charac	eristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage			V		
	IRF610-613	2.0	4.0		I <sub>D</sub> = 250 μA, V <sub>DS</sub> = V <sub>GS</sub>	
	MTP2N18/20	2.0	4.5		ID = 1 mA, VDS = VGS	
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance <sup>2</sup>			Ω	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.25 A	
	IRF610/611		1.5			
	IRF612/613		2.4	]	I <sub>D</sub> = 1.0 A	
	MTP2N18/20		1.8			
V <sub>DS(on)</sub>	Drain-Source On-Voltage <sup>2</sup>		4.4	٧	$V_{GS} = 10 \text{ V}; I_D = 2.0 \text{ A}$	
	MTP2N18/2N20		3.6	٧	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 1.0 A; T <sub>C</sub> = 100°C	
g <sub>fs</sub>	Forward Transconductance	0.8		S (ʊ)	$V_{DS} = 10 \text{ V, } I_{D} = 1.25 \text{ A}$	
Oynamic C	haracteristics					
Ciss	Input Capacitance		200	рF	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V	
Coss	Output Capacitance		80	pF	f = 1.0 MHz	
C <sub>rss</sub>	Reverse Transfer Capacitance		25	pF		
Switching (	Characteristics (T <sub>C</sub> = 25°C, Figures 11,	12) <sup>3</sup>				
t <sub>d(on)</sub>	Turn-On Delay Time		15	ns	$V_{DD} = 50 \text{ V, } I_{D} = 1.25 \text{ A}$ $V_{GS} = 10 \text{ V, } R_{GEN} = 50 \Omega$ $R_{GS} = 50 \Omega$	
tr	Rise Time		25	ns		
t <sub>d(off)</sub>	Turn-Off Delay Time		15	ns		
tı	Fall Time		15	ns		
Qg	Total Gate Charge		7.5	nC	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.0 A V <sub>DD</sub> = 45 V	
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## IRF610-613 MTP2N18/2N20

<b>Electrical Characteristics</b>	(Cont.)	$(T_C = 25^{\circ}C$	unless	otherwise	noted)
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Symbol Characteristic		Typ Max Unit		Unit	Test Conditions	
Source-Dr	ain Diode Characteristics					
V <sub>SD</sub>	Diode Forward Voltage IRF610/611		2.0	٧	I <sub>S</sub> = 2.5 A; V <sub>GS</sub> = 0 V	
	IRF612/613		1.8	٧	I <sub>S</sub> = 2.0 A; V <sub>GS</sub> = 0 V	
t <sub>rr</sub>	Reverse Recovery Time	290		ns	$I_S = 2.5 \text{ A}; dI_S/dt = 25 \text{ A}/\mu\text{S}$	

- Notes 1.  $T_1 = +25^{\circ}C$  to  $+150^{\circ}C$  2. Pulse test: Pulse width  $\leq 80~\mu s$ , Duty cycle  $\leq 1\%$  3. Switching time measurements performed on LEM TR-58 test equipment.

### **Typical Performance Curves**

Figure 1 Output Characteristics

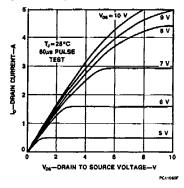


Figure 3 Transfer Characteristics

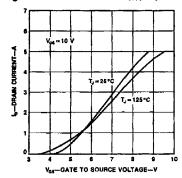


Figure 2 Static Drain to Source Resistance vs Drain Current

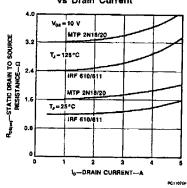


Figure 4 Temperature Variation of Gate to Source Threshold Voltage

